

Search Notes

Application/Control No.

10/527,068

Examiner

Sin J. Lee

Applicant(s)/Patent under
Reexamination

OCHIAI ET AL.

Art Unit

1795

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST TEXT Search	12-10 -07	SJL